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Application/Control No.	Applicant(s)/Patent under Reexamination
10/052,268	KOBAYASHI, NAOFUMI
Examiner	Art Unit
Andrew Lee	2616

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
Updated Search	,	9/29/2006	AL
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